

<b>Notice of References Cited</b>	Application/Control No. 10/621,453	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner sang nguyen	Art Unit 2877	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,236,327	05-2001	Yen et al.	340/673
	B	US-6,075,334	06-2000	Sagues et al.	318/568.11
	C	US-5,980,194	11-1999	Freerks et al.	414/754
	D	US-5,783,834	07-1998	Shatas, Steven C.	250/559.33
	E	US-5,605,428	02-1997	Birkner et al.	414/331.15
	F	US-5,546,179	08-1996	Cheng, David	356/73
	G	US-5,466,945	11-1995	Brickell et al.	250/559.12
	H	US-5,319,216	06-1994	Mokuo et al.	250/559.4
	I	US-4,899,195	02-1990	Gotoh, Manabu	355/77
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.